Device Modeling Report

COMPONENTS: OPERATIONAL AMPLIFIER

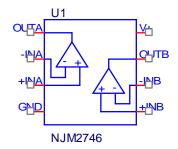
PART NUMBER: NJM2746

MANUFACTURER: NEW JAPAN RADIO



Bee Technologies Inc.

SPICE MODEL

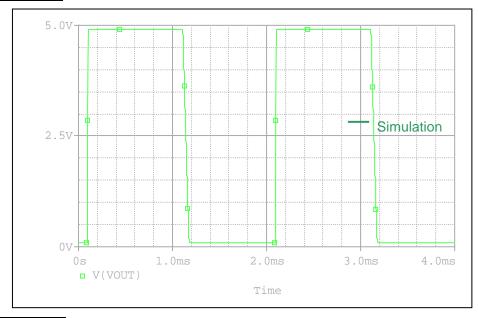


```
*$
*PART NUMBER: NJM2746
*MANUFACTURER: NEW JAPAN RADIO
*OPAMP
*All Rights Reserved Copyright (c) Bee Technologies Inc. 2005
.subckt njm2746 OUTA -INA +INA GND +INB -INB OUTB V+
X_U1 +INA -INA V+ GND OUTA njm2746_s
X U2 +INB -INB V+ GND OUTB njm2746 s
.ends njm2746
.subckt njm2746_s 1 2 3 4 5
 c1
       11 12 7.9386E-12
 c2
       6 7 27.500E-12
 dc
       5 53 dy
 de
     54 5 dy
 dlp 90 91 dx
 dln 92 90 dx
       4 3 dx
 dp
 egnd 99 0 poly(2) (3,0) (4,0) 0 .5 .5
 fb
       7 99 poly(5) vb vc ve vlp vln 0 373.25E3 -1E3 1E3 370E3 -370E3
        6 0 11 12 1.9038E-3
 ga
 gcm
        0 6 10 99 321.43E-9
       3 10 dc 99.200E-6
 iee
 hlim 90 0 vlim 1K
 q1
      11 2 13 qx1
       12 1 14 qx2
 q2
       6 9 100.00E3
 r2
       4 11 525.26
 rc1
 rc2
      4 12 525.26
     13 10 2.7495
 re1
 re2 14 10 2.7495
 ree 10 99 2.0161E6
 ro1
       8 5 50
      7 99 25
 ro2
       3 4 83.471
  rp
```

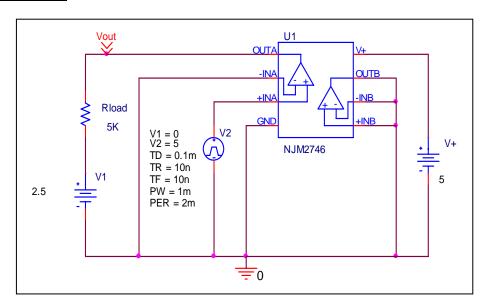
```
vb
       9 0 dc 0
      3 53 dc .89791
 VC
      54 4 dc .8085
 ve
 vlim 7 8 dc 0
 vlp 91 0 dc 20
       0 92 dc 20
 vln
.model dx D(Is=800.00E-18)
.model dy D(Is=800.00E-18 Rs=1m Cjo=10p)
.model qx1 PNP(Is=800.00E-18 Bf=494.75)
.model qx2 PNP(ls=842.2140E-18 Bf=495.25)
.ends njm2746_s
*$
```

Output Voltage Swing

Simulation result



Evaluation circuit

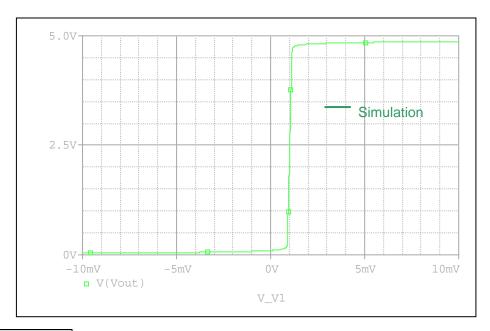


Comparison Table

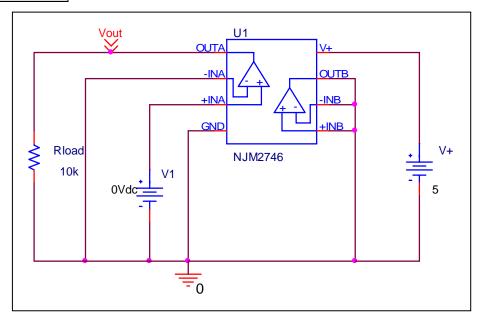
$R_L = 5 \text{ k}\Omega \text{ to } 2.5 \text{ V}$	Measurement	Simulation	%Error
V _{OH} (V)	4.9	4.9002	0.004
V _{OL} (V)	0.1	0.099967	-0.033

Input Offset Voltage

Simulation result



Evaluation Circuit

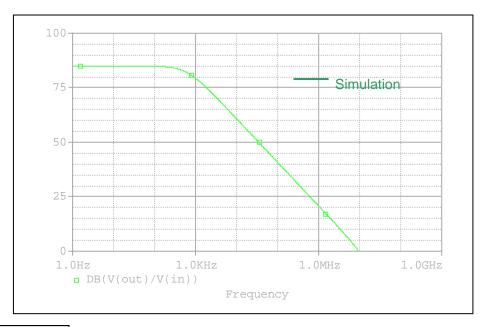


Comparison Table

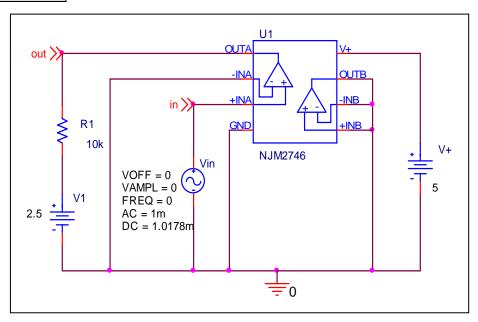
Input offset Voltage	Measurement	Simulation	%Error
V _{os} (mV)	1	1.0178	1.780

Open loop Voltage Gain

Simulation result



Evaluation Circuit

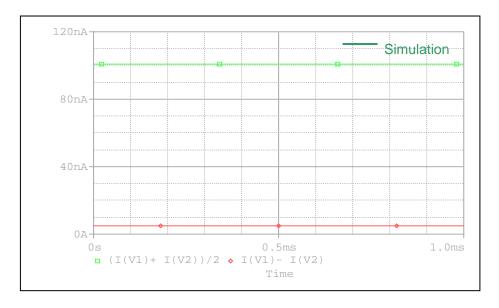


Comparison Table

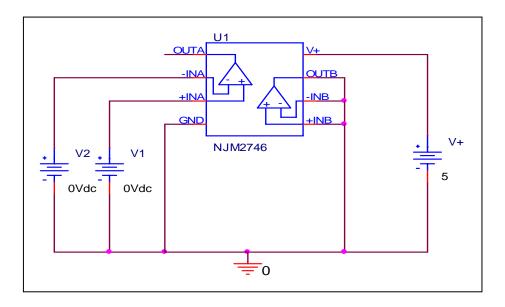
	Measurement	Simulation	% Error
Av (dB)	85	85.005	0.006

Input Current

Simulation result



Evaluation Circuit

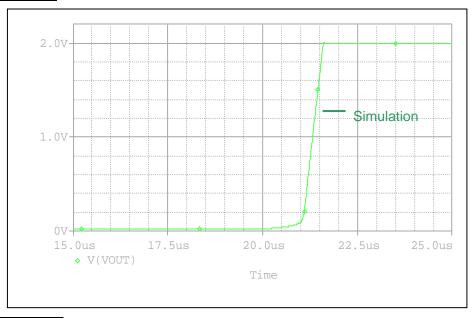


Comparison Table

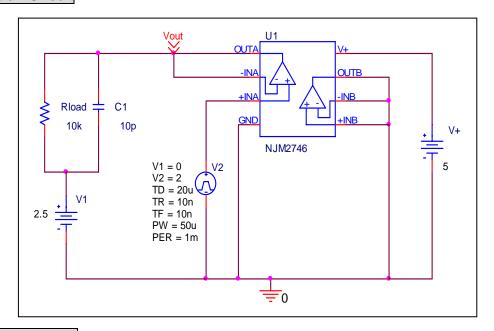
Input Current	Measurement	Simulation	% Error
I _b (nA)	100	100.928	0.928
I _{bos} (nA)	5	5.0595	1.190

Slew Rate

Simulation result



Evaluation Circuit

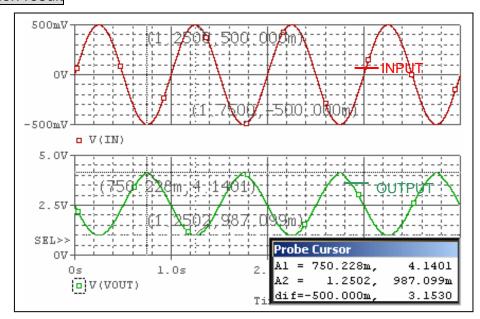


Comparison Table

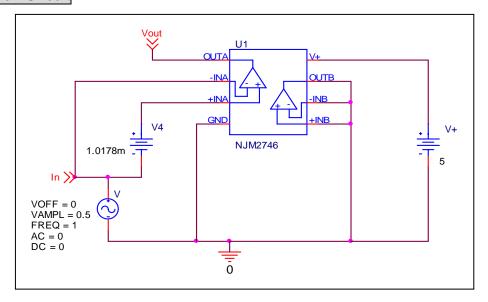
Slew Rate	Measurement	Simulation	%Error
SR (V/us)	3.5	3.575	2.143

Common-Mode Rejection Ratio

Simulation result



Evaluation Circuit



CMRR = AV/ACM = 17793/(3.153/1)

Comparison Table

	Measurement	Simulation	% Error
CMRR (dB)	75	75.031	0.041